EXPRESS MAIL CERTIFICATE

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I hereby certify that this INFORMATION DISCLOSURE STATEMENT AND FORM PTO-1449 are being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 C.F.R. 1.10 on the date indicated above and is addressed to: Mail Stop Patent Application, Commissioner For Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

By: Barbara Brazier

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF

: SEEMANN, et al.

FOR

: CONTEXT QUANTIFIER TRANSFORMATION

IN XML QUERY REWRITE

SERIAL NO.

: Unknown

FILED

: Herewith

EXAMINER

: Unknown

ART UNIT

: Unknown

CONFIRMATION NO.

: Unknown

ATTORNEY DOCKET NO.

: SVL920030087US1

INFORMATION DISCLOSURE STATEMENT

Mail Stop Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with 37 C.F.R. §§ 1.56, 1.97, 1.98 and MPEP § 609, applicants submit the following Disclosure Statement concerning art of which the applicants are aware. A copy of PTO-1449 is enclosed herewith.

This Information Disclosure Statement is not intended to constitute an admission that any patent, publication or other information referred to herein or submitted herewith is "prior art" for this invention unless specifically designated as such.

In accordance with 37 C.F.R. §1.97(g) and (h), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 C.F.R. §1.56(b) exists.

Under § 1.98(a)(3), no concise explanation of relevance is required for information that is in the English language. Accordingly, the enclosed patent requires no further explanation (or no translation is available).

U.S. Patent Document(s):

AA- US 2003/0070144 - Schnelle, et al. AB- 5,987,455 - Cochrane, et al.

Other Art:

AP- Processing XML View Queries Including User-defined Foreign Functions on Relational Databases; YOSHIHARU ISHIKAWA, et al.; Institute of Information Science and Electronics, Graduate School in Systems and Information Engineering, University of Tsukuba; Proceedings of the 3rd International Conference on Web Information Systems Engineering- 2002 IEEE Computer Society.

AQ- A Comprehensive XQuery to SQL Translation using Dynamic Interval Encoding; DAVID DEHAAN, et al.; University of Waterloo, School of Computer Science, Waterloo, Canada.

AR- Active XQuery; ANGELA BONIFATI, et al.; Dipartimento de Electronica e Informazione, Politecnico di Milano; Piazza Leonardo de vinci 32, I-20133 Milano, Italy; Proceedings of the 18 International Conference on Data Engineering- 2002 IEEE Computer Society.

AS- Integrating Hetrogeneous Data Sources with XML and XQuery; G. GARDARIN, et al.; e-XMLMedia, 31 Avenue du General Leclerc, 92,340 Bourg LaReine, France; Proceedings of the 13th International Workshop on Database and Expert Systems Applications- 2002 IEEE Computer Society.

AT- Querying XML Databases; ARTUR AFONSO DE SOUSA, et al.; Escola Superior de Tecnologia de Viseu, Departmento de Informatica, Portugal - Universidade do Minho, Department de Sistemas de Informacao, Guimares, Portugal; Proceedings of the XXII International Conference of the Chilean Computer Science Society- 2002 IEEE Computer Society.

AU- Towards Declarative XML Querying; MENGCHI LIU, et al.; School of Computer Science, Carleton University, Ottawa, Ontario, Canada K1S 5B6; Proceedings of the 3rd International Conference on Web Information Systems Engineering - 2002 IEEE Computer Society.

AV- Optimized Translation of XPath into Algebraic Expressions Parameterized by Programs Containing Navigational Primitives; SVEN HELMER, et al.; University of Mannheim, Germany; Proceedings of the 3rd International Conference on Web Information Systems Engineering-2002 IEEE Computer Society.

AW- Extensible/Rule Based Query Rewrite Optimization in Starburst; Hamid PIRAHESH, et al.; IBM Almaden Research Center; San Jose, CA 95120.

Consideration of the appropriate paragraph(s) indicated below is respectfully requested:

[X] WITHIN THREE MONTHS OF FILING: Under § 1.97(b)(1), this Information Disclosure Statement is being filed within three months of the filing date of the application. Although it is believed no fee is necessary, any deficiency in fees should be charged to Deposit Account No. 09-0460.

It is respectfully requested that the attached document(s) be considered and officially cited in examination of this application.

Respectfully submitted,

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Substitute for form 1449/PTO			Complete if Known					
INFORMATION DISCLOSURE			Application Number			Unknown		
			Filing Date			Herewith		
STATE	MENT	BY APPLICANT(S)	First Named Inventor			Seemann, et al.		
(Use	as many	sheets as necessary)	Art Unit			Unknown		
			Examiner Name			Unknown		
	Sh	eet 1 of 1	Attorney Docket Number		SVL920030087US1			
			U.S. P	ATENT	DOCUM	ENTS		
Examiner Initials*	Cite No.	Document No. Number-Kind Code (f known)	Publication MM-DD-Y			Name of Patentee or icant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	AA	US-2003/0070144 A1	0410-2003		Schnelle, et al.			
	AB	US-5,987,455	11-16-199	9	Cochrane, et al.			
	486							
			FOREIGN	I PATEN	IT DOC	UMENTS		
Examiner Initials*	Cite No.	Foreign Patent Document		Publication Date MM-DD-YYYY		Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	7
	AP	Processing XML View Queries Including User-defined Foreign Functions on Relational Databases; YOSHIHARU ISHIKAWA, et al.;Institute of Information Science and Electronics, Graduate School in Systems and Information Engineering, University of Tsukuba; Proceedings of the 3rd International Conference on Web Information Systems Engineering- 2002 IEEE Computer Society.	Î
	AQ	A Comprehensive XQuery to SQL Translation using Dynamic Interval Encoding; DAVID DEHAAN, et al.; University of Waterloo, School of Computer Science, Waterloo, Canada.	
	AR	Active XQuery; ANGELA BONIFATI, et al.; Dipartimento de Electronica e Informazione, Politecnico di Milano; Piazza Leonardo de vinci 32, I-20133 Milano, Italy; Proceedings of the 18 International Conference on Data Engineering- 2002 IEEE Computer Society.	
	AS	Integrating Hetrogeneous Data Sources with XML and XQuery; G. GARDARIN, et al.; e-XMLMedia, 31 Avenue du General Leclerc, 92340 Bourg LaReine, France; Proceedings of the 13th International Workshop on Database and Expert Systems Applications- 2002 IEEE Computer Society.	
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	AW	Extensible/Rule Based Query Rewrite Optimization in Starburst; Hamid PIRAHESH, et al.; IBM Almaden Research Center; San Jose, CA 95120.	

Examiner	Date	
Signature	Considered	